

## **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub> Max T <sub>A</sub> = +25°C			
Q2	30V	21mΩ @ V <sub>GS</sub> = 10V	8.5A			
QZ	Q2 30V	30 v	30 v		32mΩ @ V <sub>GS</sub> = 4.5V	7.2A
01	Q1 -30V -	39mΩ @ V <sub>GS</sub> = -10V	-7A			
QT		53mΩ @ V <sub>GS</sub> = -4.5V	-5.6A			

## **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- **Power Management Functions**
- Analog Switch
- Load Switch

### Features

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- **Complementary Pair MOSFET**
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

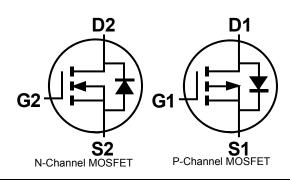
## Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame Solderable per MIL-STD-202, Method 208 3
- Weight: 0.072 grams (approximate)



7 D2 G2 2 6 D1 S1 3 G1 4 Top View

S2[1



## Ordering Information (Note 5)

Part Number	Case	Packaging
DMC3021LSDQ-13	SO-8	2,500/Tape & Reel

SO-8

8 D2

5 D1

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

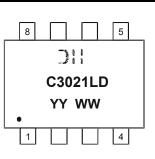
2. See http://www.diodes.com/quality/lead free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product\_grade\_definitions/.

5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

## Marking Information



311 = Manufacturer's Marking C3021LD = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 14 = 2014) WW = Week (01 - 53) YY = Date Code Marking



## Maximum Ratings N-CHANNEL – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Char	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	30	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 6)	ID	8.5 7.1	А
Pulsed Drain Current (Note 7)	I <sub>DM</sub>	26	А

## Maximum Ratings P-CHANNEL – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Char	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-30	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 6)	ID	-7.0 -4.5	А
Pulsed Drain Current (Note 7)	I <sub>DM</sub>	-25	A

## **Thermal Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 6)	PD	2.5	W
Thermal Resistance, Junction to Ambient (Note 6)	R <sub>θJA</sub>	50	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	С°

## Electrical Characteristics N-CHANNEL – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

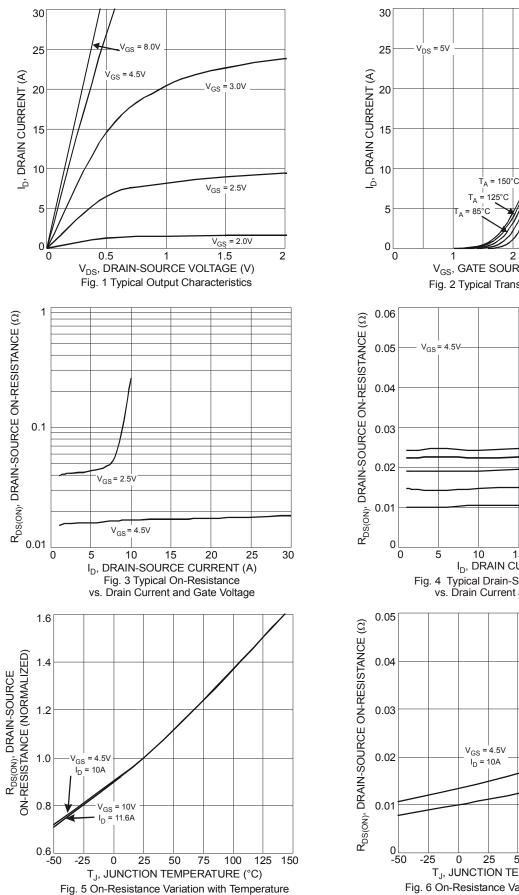
Characteristic	Symbol	Min	Тур	Мах	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	—	—	V	$V_{GS}$ = 0V, I <sub>D</sub> = 250µA	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	1.0	μA	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS}$ = ±20V, $V_{DS}$ = 0V	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	1	1.45	2.1	V	$V_{DS} = V_{GS}, I_{C} = 250 \mu A$	
Static Drain-Source On-Resistance	Deserve	_	14	21	mΩ	V <sub>GS</sub> = 10V, I <sub>C</sub> = 7A	
	R <sub>DS (ON)</sub>		18	32	11122	V <sub>GS</sub> = 4.5V, I <sub>C</sub> = 5.6A	
Forward Transfer Admittance	Y <sub>fs</sub>		8.1	—	S	$V_{DS} = 5V, I_{C} = 7A$	
Diode Forward Voltage (Note 8)	V <sub>SD</sub>	_	0.7	1.0	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	Ciss	_	767	_	pF		
Output Capacitance	Coss		110	—	pF	−V <sub>DS</sub> = 10V, V <sub>GS</sub> = 0V, −f = 1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	105	_	pF		
Gate Resistance	Rg	_	1.4		Ω	$V_{DS}$ = 0V, $V_{GS}$ = 0V, f = 1MHz	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	7.8	_	nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	16.1	_	nC	(-15)(00)	
Gate-Source Charge	Q <sub>gs</sub>	_	1.8		nC	– V <sub>DS</sub> = 15V, I <sub>D</sub> = 9A	
Gate-Drain Charge	Q <sub>gd</sub>	_	2.5		nC	7	
Turn-On Delay Time	t <sub>D(on)</sub>	_	5.0		ns		
Turn-On Rise Time	tr		4.5	—	ns	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V,	
Turn-Off Delay Time	t <sub>D(off)</sub>		26.3	—	ns	$R_G = 6\Omega$ , $I_D = 1A$	
Turn-Off Fall Time	t <sub>f</sub>		8.55	—	ns		

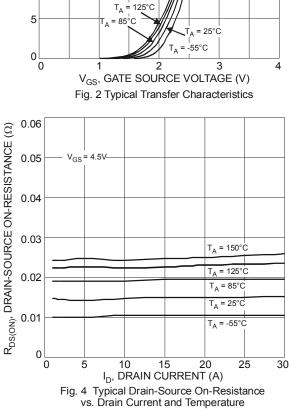
6. Device mounted on FR-4 PCB, with minimum recommended pad layout.

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Notes:







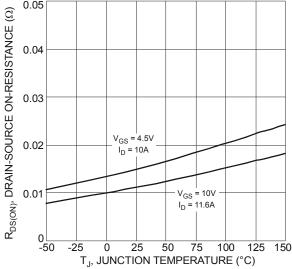
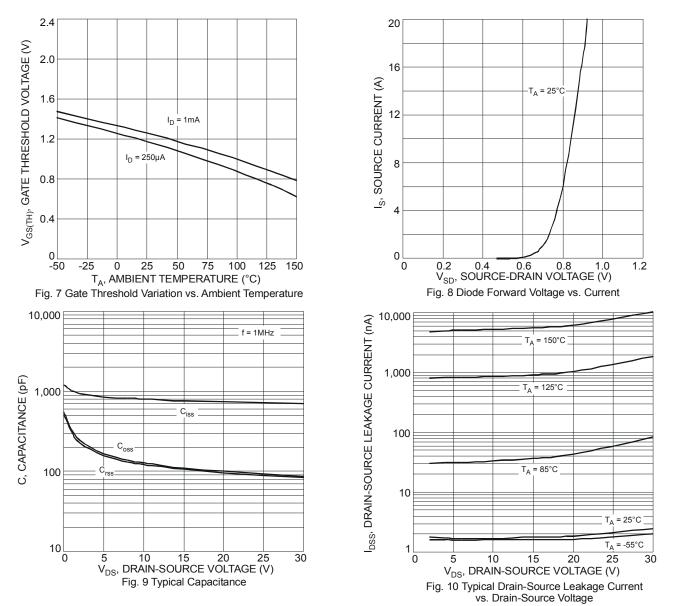


Fig. 6 On-Resistance Variation with Temperature





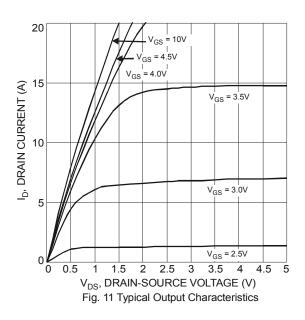


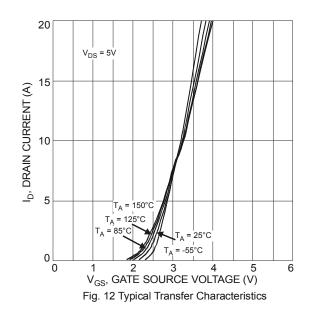
## Electrical Characteristics P-CHANNEL – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Мах	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	—	—	V	$V_{GS} = 0V, I_D = -250 \mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>		—	-1.0	μA	$V_{DS}$ = -30V, $V_{GS}$ = 0V	
Gate-Source Leakage	I <sub>GSS</sub>		—	±100	nA	$V_{GS}$ = ±20V, $V_{DS}$ = 0V	
ON CHARACTERISTICS (Note 8)			-				
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1	-1.7	-2.2	V	$V_{DS}$ = $V_{GS}$ , $I_D$ = -250 $\mu$ A	
Static Drain-Source On-Resistance	Proven		30	39	mΩ	$V_{GS}$ = -10V, $I_{D}$ = -4.3A	
	R <sub>DS(ON)</sub>	_	42	53	11152	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -3.7A	
Forward Transfer Admittance	Y <sub>fs</sub>	_	7	_	S	V <sub>DS</sub> = -5V, I <sub>D</sub> = -4.3A	
Diode Forward Voltage (Note 8)	V <sub>SD</sub>	_	-0.75	-1.0	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1.7A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C <sub>iss</sub>	_	1002	_	pF		
Output Capacitance	Coss	_	125	_	pF	V <sub>DS</sub> = -10V, V <sub>GS</sub> = 0V, f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	118		pF		
Gate Resistance	Rg	_	13		Ω	$V_{DS}$ = 0V, $V_{GS}$ = 0V, f = 1MHz	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	10.1		nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg		21.1	—	nC		
Gate-Source Charge	Q <sub>gs</sub>		2.8	—	nC	– V <sub>DS</sub> = -15V, I <sub>D</sub> = -6A	
Gate-Drain Charge	Q <sub>gd</sub>		3.2	—	nC	7	
Turn-On Delay Time	t <sub>D(on)</sub>	_	10.1	—	ns		
Turn-On Rise Time	tr	_	6.5	—	ns	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V,	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	50.1	—	ns	$R_G = 6\Omega$ , $I_D = -1A$	
Turn-Off Fall Time	tf	_	22.2	_	ns		

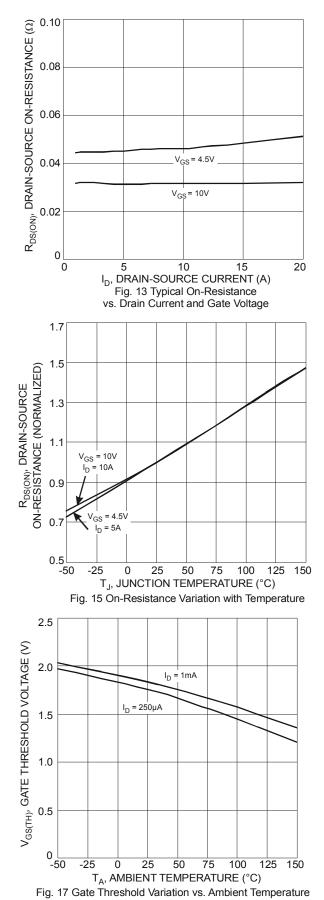
Notes: 8. Short duration pulse test used to minimize self-heating effect.

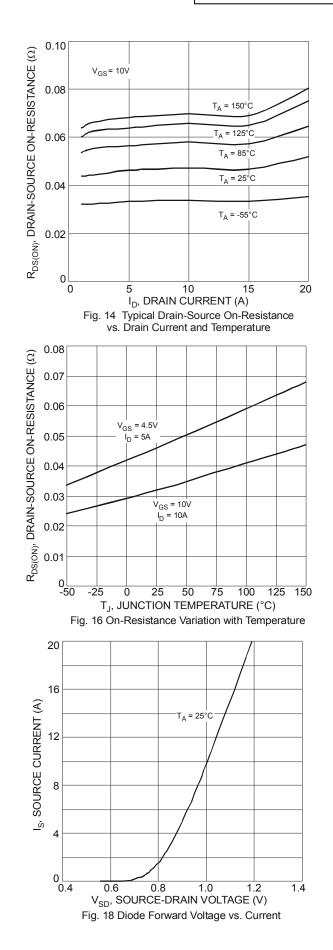
9. Guaranteed by design. Not subject to production testing.



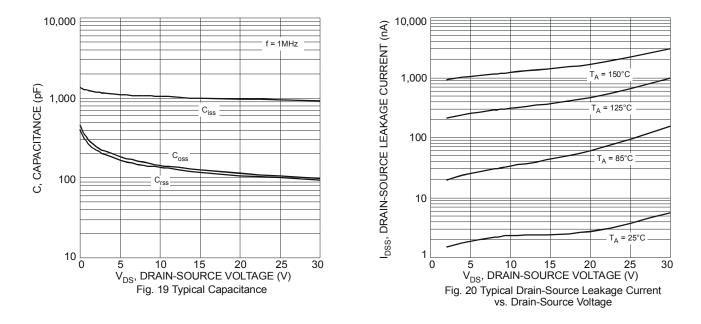






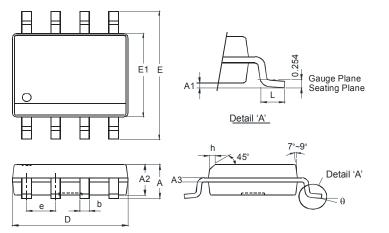






## **Package Outline Dimensions**

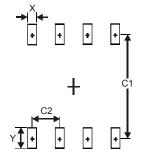
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8						
Dim	Min Max					
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
E	5.90	6.10				
E1	3.85	3.95				
е	1.27	Тур				
h	- 0.35					
L	0.62	0.82				
θ	0°	8°				
All Di	mensions	in mm				

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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